

FCC Test Report

Report No. : 1812C40178312504

Shenzhen SOYES Premium Technology Applicant

limited

Building 521, 305, Bagualing Industrial Zone,

Address : 255 Baguagsan Road, Hualin Community,

Yuanling, Futian, Shenzhen, 518000, China

Product Name : Mini smartphone

Report Date : Jan. 22, 2025

Shenzhen Anbotek Compliance Laboratory Limited

Hotline 400-003-0500 www.anbotek.com





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TEST REPORT

Applicant : Shenzhen SOYES Premium Technology limited

: Shenzhen SOYES Premium Technology limited Manufacturer

Product Name : Mini smartphone

XS18Pro, XS19, XS19Pro, XS20, XS20Pro, XS21, XS21Pro, XS22,

XS22Pro, XS23, XS23Pro, XS24, XS24Pro, XS25, XS25Pro, XS26, Model No.

XS26Pro, XS28, XS28Pro, XS18Max, XS14Pro, XS15, XS16, XS16Pro,

16mini, S24ProMax, XS18ProMax

Trade Mark : SOYES

Input: 5V-500mA Rating(s)

Battery Capacity: DC 3.8V, 900mAh

Test Standard(s) : 47 CFR Part 2, 47 CFR Part 22(H), 47 CFR Part 24(E)

ANSI C63.26-2015

Test Method(s) KDB 971168 D01 Power Meas License Digital Systems v03r01

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the 47 CFR Part 22, 47 CFR Part 24 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt	Dec. 13, 2024	
Date of Test : :	Dec. 13, 2024 to Jan. 06, 2025	
: Prepared by :	Cecilia Chen	
	(Cecilia Chen)	
: Approved & Authorized Signer :	Engkongfin	
	(KingKong Jin)	

Shenzhen Anbotek Compliance Laboratory Limited





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Revision History

Report Version	Description	Issued Date
R00	Original Issue.	Jan. 22, 2025



1. General Information

1.1. Client Information

Applicant	:	Shenzhen SOYES Premium Technology limited
Address	:	Building 521, 305, Bagualing Industrial Zone, 255 Baguagsan Road, Hualin Community, Yuanling, Futian, Shenzhen, 518000, China
Manufacturer	rer : Shenzhen SOYES Premium Technology limited	
Address	:	Building 521, 305, Bagualing Industrial Zone, 255 Baguagsan Road, Hualin Community, Yuanling, Futian, Shenzhen, 518000, China
Factory	: Shenzhen SOYES Premium Technology limited	
Address	:	Building 521, 305, Bagualing Industrial Zone, 255 Baguagsan Road, Hualin Community, Yuanling, Futian, Shenzhen, 518000, China

1.2. Description of Device (EUT)

Product Name	:	Mini smartphone		
		XS18Pro, XS19, XS19Pro, XS20, XS20Pro, XS21, XS21Pro, XS22,		
		XS22Pro, XS23, XS23Pro, XS24, XS24Pro, XS25, XS25Pro, XS26,		
Model No.	:	XS26Pro, XS28, XS28Pro, XS18Max, XS14Pro, XS15, XS16, XS16Pro,		
	•	16mini, S24ProMax, XS18ProMax		
		(Note: All samples are the same except the model number and color and		
		appearance, so we prepare "XS18Pro" for test only.)		
Trade Mark	:	SOYES		
Test Power Supply	:	DC 3.8V battery inside		
Test Sample No.	:	1-2-1(Normal Sample), 1-2-2(Engineering Sample)		
Adapter	:	N/A		
RF Specification				
Support Band	:	⊠FDD Band II ⊠FDD Band V □FDD Band IV		
Transmit Frequency		FDD Band II: 1852.40MHz~1907.60MHz		
	Ŀ	FDD Band V: 826.40MHz~846.60MHz		
Receive Frequency		FDD Band II: 1932.40MHz~1987.60MHz		
	Ŀ	FDD Band V: 871.40MHz~891.60MHz		
Modulation Type	:	QPSK		
Power Class	:	Class 3		
Antenna Type	:	FPC Antenna		
Antenna Gain(Peak):		FDD Band II: 0.5dBi		
FDD Band V: 0.4dBi		FDD Band V: 0.4dBi		
Remark: 1) All of the RF specification are provided by customer. 2) For a more detailed features				

description, please refer to the manufacturer's specifications or the User's Manual. Code:AB-RF-05-b





1.3. Auxiliary Equipment Used During Test

Title	Manufacturer	Model No.	Serial No.
1	1	1	1

1.4. Operation State

Test frequency list:

FDD E	Band II	FDD E	Band V
Channel Frequency (MHz)		Channel	Frequency (MHz)
9262 1852.40		4132	826.40
9400	1880.00	4183	836.60
9538	1907.60	4233	846.60

Test mode:

Antenna port conducted and radiated test items were performed according to KDB 971168 D01 Power Meas. License Digital Systems v03 and ANSI C63.26-2015 with maximum output power.

Radiated measurements were performed with rotating EUT in different three orthogonal test planes to find the maximum emission.

Radiated emissions were investigated as following frequency range:

30 MHz to 10th harmonic for FDD Band II, Band V.

All modes and data rates and positions were investigated.

Test modes are chosen to be reported as the worst case configuration below:

Test modes				
Band	Radiated	Conducted		
FDD Band II	■ RMC 12.2Kbps Link	■ RMC 12.2Kbps Link		
FDD Band V	■ RMC 12.2Kbps Link	■ RMC 12.2Kbps Link		

1.5. Environmental Conditions

Temperature range:	21-25°C
Humidity range:	40-75%
Pressure range:	86-106kPa





1.6. Test Equipment List

	1.0. Test Equipment List					
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	EMI Preamplifier	SKET Electronic	LNPA-0118G- 45	SKET-PA-002	Jan. 17, 2024	1 Year
2.	EMI Test Receiver	Rohde & Schwarz	ESR26	101481	Jan. 23, 2024	1 Year
3.	Double Ridged Horn Antenna	SCHWARZBECK	BBHA 9120D	02555	Oct. 16, 2022	3 Year
4.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	345	Oct. 23, 2022	3 Year
5.	Pre-amplifier	SONOMA	310N	186860	Jan. 17, 2024	1 Year
6.	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A
7.	MXA Spectrum Analysis	Agilent	N9020A	MY51170037	Sept. 09, 2024	1 Year
8.	MXG RF Vector Signal Generator	Agilent	N5182A	MY48180656	Feb. 04, 2024	1 Year
9.	DC Power Supply	LW	TPR-6420D	374470	Oct. 17, 2024	1 Year
10.	Constant Temperature Humidity Chamber	ZHONGJIAN	ZJ-KHWS80B	N/A	Oct. 14, 2024	1 Year
11.	Wideband Radio Communication Tester	Rohde & Schwarz	CMW 500	167336	Feb. 04, 2024	1 Year
12.	High-Pass Filter	CDKMV	ZHPF-BM110 0-4000-0730	B2015094550	Oct. 17, 2024	1 Year
13.	High-Pass Filter	CDKMV	ZHPF-M3.5-18 G-3834	1307006523	Oct. 17, 2024	1 Year
14.	Bilog Broadband Antenna	SCHWARZBECK	VULB 9163	01109	Oct. 16, 2022	3 Year
15.	Double Ridged Horn Antenna	Chengyi Electronics Co., Ltd.	GTH-0118	351600	Nov. 02, 2022	2 Year





1.7. Measurement Uncertainty

Parameter	Uncertainty
Occupied Bandwidth	925Hz
Conducted Output Power	0.76dB
Conducted Spurious Emission	1.24dB
Radiated spurious emissions (30MHz~1GHz)	Horizontal: 3.92dB; Vertical: 4.52dB
Radiated spurious emissions (above 1GHz)	1G-6GHz: 4.78dB; 6G-18GHz: 4.88dB

The measurement uncertainty and decision risk evaluated according to AB/WI-RF-F-032.

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

1.8. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 434132

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 434132.

ISED-Registration No.: 8058A

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.

Sogood Industrial Zone Laboratory & 1/F. of Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Subdistrict, Bao'an District, Shenzhen, Guangdong, China.





1.9. Disclaimer

- 1. The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- 2. The test report is invalid if there is any evidence and/or falsification.
- 3. The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
- 4. This document may not be altered or revised in any way unless done so by Anbotek and all revisions are duly noted in the revisions section.
- 5. Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
- 6. The authenticity of the information provided by the customer is the responsibility of the customer and the laboratory is not responsible for its authenticity.

The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.



2. Summary of Test

2.1. Summary of test result

FCC Rules	Description of Test	Result	
Part 2.1046 Part 22.913(a)	Conducted Output Power	Compliance	
Part 24.232(c)	·	•	
Part 24.232	Peak-Average Ratio	Compliance	
§ 2.1047	Modulation Characteristics	N/A	
Part 2.1049	99% Occupied Bandwidth & 26 dB Bandwidth	Compliance	
Part 2.1051			
Part 22.917	Conducted Spurious Emission	Compliance	
Part 24.238			
Part 2.1051			
Part 22.917	Band Edge	Compliance	
Part 24.238			
Part 2.1055(a)(1)(b)			
Part 22.355	Frequency stability VS. temperature	Compliance	
Part 24.235			
Part 2.1055(d)(1)(2)			
Part 22.355	Frequency stability VS. voltage	Compliance	
Part 24.235			
Part 2.1046			
Part 22.913(a)	ERP and EIRP	Compliance	
Part 24.232(c)			
Part 2.1053			
Part 22.917	Radiated Spurious Emission Compliance		
Part 24.238			

Note: Testing was performed by configuring EUT to maximum output power status, the declared output power class for different



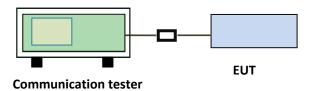


3. Conducted Output Power Test

3.1. Test Standard and Limit

Applicable Standard:	Part 2.1046
	Part 22.913(a)
	Part 24.232(c)
Limit:	N/A

3.2. Test Setup



3.3. Test Procedure

- 1. The EUT output port was connected to communication tester.
- 2. Set EUT at maximum power through communication tester.
- 3. Select lowest, middle, and highest channels for each band and different modulation.
- 4. Measure the maximum burst average power.

3.4. Test Data

Pass

Please refer to Appendix A of the Appendix Test Data.



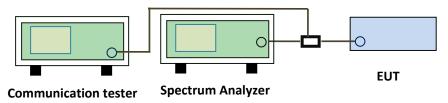


4. Peak-Average Ratio

4.1. Test Standard and Limit

Applicable Standard:	Part 24.232
Limit:	13dB

4.2. Test Setup



4.3. Test Procedure

According with KDB 971168 D01 Section 5.7:

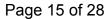
- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter.
 - 2. Set EUT in maximum power output.
 - 3. Center Frequency = Carrier frequency, RBW > Emission bandwidth of signal.
 - 4. The signal analyzer was set to collect one million samples to generate the CCDF curve.
 - 5. The measurement interval was set depending on the type of signal analyzed.
 - i. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms.
- ii. For burst transmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that is synced with an incoming pulse and the measurement interval is set to less than the duration of the "on time" of one burst to ensure that energy is only captured during a time in which the transmitter is operating at maximum power
 - 6. Record the maximum PAPR level associated with a probability of 0.1%.

4.4. Test Data

Pass

Please refer to Appendix B of the Appendix Test Data.







5. Modulation Characteristic

According to FCC § 2.1047(d), Part 22H, Part 24E there is no specific requirement for digital modulation, therefore modulation characteristic is not presented.

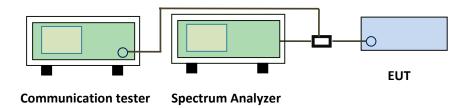


6. 99% Occupied Bandwidth & 26 dB Bandwidth

6.1. Test Standard and Limit

Applicable Standard:	Part 2.1049
Limit:	N/A

6.2. Test Setup



6.3. Test Procedure

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter.
- 2. Set EUT in maximum power output.
- Spectrum analyzer setting as follow:
 Center Frequency= Carrier frequency, RBW=1% to 5% of anticipated OBW, VBW= 3 *
 RBW, Detector=Peak,
 Trace maximum hold.
- 4. Record the value of 99% Occupied bandwidth and -26dB bandwidth.

6.4. Test Data

Pass

Please refer to Appendix C of the Appendix Test Data.

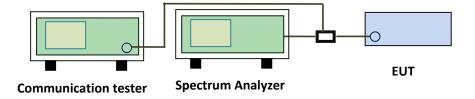


7. Band Edge

7.1. Test Standard and Limit

Applicable Standard:	Part 2.1051 Part 22.917
	Part 24.238
Limit:	Part 24.238 and Part 22.917 specify that the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB.
	The specification that emissions shall be attenuated below the transmitter power (P) by at least 43 + 10 log (P) dB, translates in the relevant power range (1 to 0.001 W) to -13 dBm. At 1 W the specified minimum attenuation becomes 43 dB and relative to a 30 dBm (1 W) carrier becomes a limit of -13 dBm. At 0.001 W (0 dBm) the minimum attenuation is 13 dB, which again yields a limit of -13 dBm. In this way a translation of the specification from relative to absolute terms is carried out.

7.2. Test Setup



7.3. Test Procedure

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter.
- 2. Set EUT in maximum power output.
- 3. The band edges of low and high channels were measured.
- 4. Spectrum analyzer setting as follow: RBW=3KHz, VBW = 10KHz, Sweep time= Auto
- 5. Record the test plot.

7.4. Test Data

Pass

Please refer to Appendix D of the Appendix Test Data.



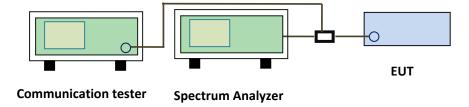


8. Conducted Spurious Emission

8.1. Test Standard and Limit

Applicable Standard:	Part 2.1051 Part 22.917
	Part 24.238
Limit:	Part 24.238 and Part 22.917 specify that the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB.
	The specification that emissions shall be attenuated below the transmitter power (P) by at least 43 + 10 log (P) dB, translates in the relevant power range (1 to 0.001 W) to -13 dBm. At 1 W the specified minimum attenuation becomes 43 dB and relative to a 30 dBm (1 W) carrier becomes a limit of -13 dBm. At 0.001 W (0 dBm) the minimum attenuation is 13 dB, which again yields a limit of -13 dBm. In this way a translation of the specification from relative to absolute terms is carried out.

8.2. Test Setup



8.3. Test Procedure

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter.
- 2. Set EUT in maximum power output.
- 3. Spectrum analyzer setting as follow:

Below 1GHz, RBW=100KHz, VBW = 300KHz, Detector=Peak, Sweep time= Auto Above 1GHz, RBW=1MHz, VBW=3MHz, Detector=Peak, Sweep time= Auto Scan frequency range up to 10th harmonic.

4. Record the test plot.

8.4. Test Data

Pass

Please refer to Appendix E of the Appendix Test Data.



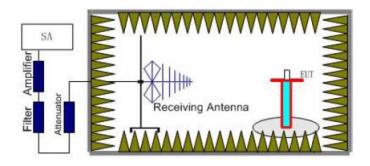


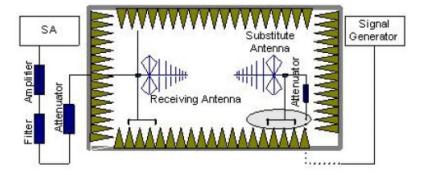
9. Radiated Spurious Emission

9.1. Test Standard and Limit

Applicable Standard:	Part 2.1053
	Part 22.917
	Part 24.238
Limit:	-13dBm

9.2. Test Setup





9.3. Test Procedure

- 1. Place the EUT in the center of the turntable.
 - a) For radiated emissions measurements performed at frequencies less than or equal to 1 GHz, the EUT shall be placed on a RF-transparent table at a nominal height of 80 cm above the reference ground plane
 - b) For radiated measurements performed at frequencies above 1 GHz, the EUT shall be placed on an RF transparent table at a nominal height of 1.5 m above the ground plane.
- 2. Unless the EUT uses an integral antenna, the EUT shall be terminated with a non-radiating transmitter load. In cases where the EUT uses an adjustable antenna, the antenna shall be adjusted through typical positions and lengths to maximize emissions levels.
- 3. The EUT shall be tested while operating on the frequency per manufacturer specification. Set the transmitter to operate in continuous transmit mode.
- 4. Receiver or Spectrum set as follow:

Below 1GHz, RBW=100kHz, VBW=300kHz, Detector=Peak, Sweep time=Auto Above 1GHz, RBW=1MHz, VBW=3MHz, Detector=Peck, Sweep time=Auto

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- 5. Each emission under consideration shall be evaluated:
 - a) Raise and lower the measurement antenna from 1 m to 4 m, as necessary to enable detection of the maximum emission amplitude relative to measurement antenna height.
 - b) Rotate the EUT through 360° to determine the maximum emission level relative to the axial position.
 - c) Return the turntable to the azimuth where the highest emission amplitude level was observed.
 - d) Vary the measurement antenna height again through 1 m to 4 m again to find the height associated with the maximum emission amplitude.
 - e) Record the measured emission amplitude level and frequency
- 6. Repeat step 5 for each emission frequency with the measurement antenna oriented in both the horizontal and vertical polarizations to determine the orientation that gives the maximum emissions amplitude.
- 7. Set-up the substitution measurement with the reference point of the substitution antenna located as near as possible to where the center of the EUT radiating element was located during the initial EUT measurement.
- 8. Maintain the previous measurement instrument settings and test set-up, with the exception that the EUT is removed and replaced by the substitution antenna.
- 9. Connect a signal generator to the substitution antenna; locate the signal generator so as to minimize any potential influences on the measurement results. Set the signal generator to the frequency where emissions are detected, and set an output power level such that the radiated signal can be detected by the measurement instrument, with sufficient dynamic range relative to the noise floor.
- 10. For each emission that was detected and measured in the initial test
 - a) Vary the measurement antenna height between 1 m to 4 m to maximize the received (measured) signal amplitude.
 - b) Adjust the signal generator output power level until the amplitude detected by the measurement instrument equals the amplitude level of the emission previously measured directly in step 5 and step 6.
 - c) Record the output power level of the signal generator when equivalence is achieved in step b).
- 11. Repeat step 8 through step 10 with the measurement antenna oriented in the opposite polarization.
- 12. Calculate the emission power in dBm referenced to a half-wave dipole using the following equation:

Pe = Ps(dBm) - cable loss (dB) + antenna gain (dBd)

where

Pe = equivalent emission power in dBm

Ps = source (signal generator) power in dBm

NOTE—dBd refers to the measured antenna gain in decibels relative to a half-wave dipole.

13. Correct the antenna gain of the substitution antenna if necessary to reference the emission power to a half-wave dipole. When using measurement antennas with the gain specified in dBi, the equivalent dipole-referenced gain can be determined from:

gain (dBd) = gain (dBi) - 2.15 dB.

If necessary, the antenna gain can be calculated from calibrated antenna factor information

14. Provide the complete measurement results as a part of the test report.

9.4. Test Data

Pass

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Note: Worst case at WCDMA Band II/ WCDMA Band V

WCDMA Band II							
	Frequency		Spurious Emission				
Channel	(MHz)	Polarization	reading (dBm)	factor (dB)	Level (dBm)	Limit (dBm)	Result
	3704.80	Vertical	-48.74	13.26	-35.48		
	5557.20	V	-55.75	16.62	-39.13	<-13.00	PASS
9262	7409.60	V	-58.10	17.84	-40.26		
9202	3704.80	Horizontal	-50.41	13.26	-37.15		
	5557.20	Н	-57.32	16.62	-40.70	<-13.00	PASS
	7409.60	Н	-59.44	17.84	-41.60		
	3760.00	Vertical	-47.49	13.27	-34.22		
	5640.00	V	-54.44	16.49	-37.95	<-13.00	PASS
9400	7520.00	V	-57.11	17.96	-39.15		
9400	3760.00	Horizontal	-48.89	13.27	-35.62		
	5640.00	Н	-55.95	16.49	-39.46	<-13.00	PASS
	7520.00	Н	-58.38	17.96	-40.42		
	3815.20	Vertical	-45.67	13.59	-32.08		
	5722.80	V	-52.69	16.69	-36.00	<-13.00	PASS
9538	7630.40	V	-55.25	17.95	-37.30		
9000	3815.20	Horizontal	-48.46	13.59	-34.87		
	5722.80	Н	-55.45	16.69	-38.76	<-13.00	PASS
	7630.40	Н	-57.77	17.95	-39.82		

Remark:

- 1. The emission behaviour belongs to narrowband spurious emission.
- 2. The emission levels of not record in the report are very lower than the limit and not show in test report.



	WCDMA Band V						
	F		Spurious Emission				
Channel	Channel Frequency (MHz)	Polarization	reading (dBm)	factor (dB)	Level (dBm)	Limit Resu	Result
	1652.80	Vertical	-38.37	5.62	-32.75		
	2479.20	V	-46.65	9.32	-37.33	<-13.00	PASS
4422	3305.60	V	-52.60	12.69	-39.91		
4132	1652.80	Horizontal	-40.07	5.62	-34.45		
	2479.20	Н	-48.25	9.32	-38.93	<-13.00	PASS
	3305.60	Н	-54.11	12.69	-41.42		
	1673.20	Vertical	-39.02	7.69	-31.33		
	2509.80	V	-45.46	9.46	-36.00	<-13.00	PASS
4400	3346.40	V	-50.92	12.26	-38.66		
4183	1673.20	Horizontal	-40.96	7.69	-33.27		
	2509.80	Н	-47.28	9.46	-37.82	<-13.00	PASS
	3346.40	Н	-52.64	12.26	-40.38		
	1693.20	Vertical	-37.92	8.26	-29.66		
	2539.80	V	-44.08	9.65	-34.43	<-13.00	PASS
4000	3386.40	V	-49.60	12.41	-37.19	<-13.00	
4233	1693.20	Horizontal	-40.14	8.26	-31.88		
	2539.80	Н	-46.17	9.65	-36.52		PASS
	3386.40	Н	-51.57	12.41	-39.16		

Remark:

- 1. The emission behaviour belongs to narrowband spurious emission.
- 2. The emission levels of not record in the report are very lower than the limit and not show in test report.

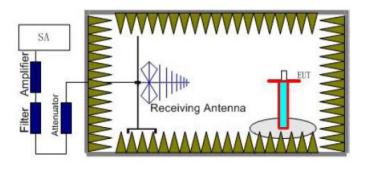


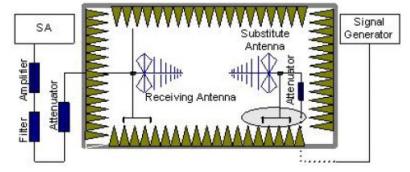
10. ERP and EIRP

10.1. Test Standard and Limit

Applicable Standard:	Part 2.1046
	Part 22.913(a)
	Part 24.232(c)
Limit:	WCDMA Band II: 2W (33dBm) EIRP
	WCDMA Band V: 7W (38.45dBm) ERP

10.2. Test Setup





10.3. Test Procedure

- 1. Place the EUT in the center of the turntable.
 - a) For radiated emissions measurements performed at frequencies less than or equal to 1 GHz, the EUT shall be placed on a RF-transparent table at a nominal height of 80 cm above the reference ground plane
 - b) For radiated measurements performed at frequencies above 1 GHz, the EUT shall be placed on an RF transparent table at a nominal height of 1.5 m above the ground plane.
- 2. Unless the EUT uses an integral antenna, the EUT shall be terminated with a non-radiating transmitter load. In cases where the EUT uses an adjustable antenna, the antenna shall be adjusted through typical positions and lengths to maximize emissions levels.
- 3. The EUT shall be tested while operating on the frequency per manufacturer specification. Set the transmitter to operate in continuous transmit mode.
- 4. Receiver or Spectrum set as follow:

Below 1GHz, RBW=100kHz, VBW=300kHz, Detector=Peak, Sweep time=Auto Above 1GHz, RBW=1MHz, VBW=3MHz, Detector=Peck, Sweep time=Auto

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- 5. Each emission under consideration shall be evaluated:
 - a) Raise and lower the measurement antenna from 1 m to 4 m, as necessary to enable detection of the maximum emission amplitude relative to measurement antenna height.
 - b) Rotate the EUT through 360° to determine the maximum emission level relative to the axial position.
 - c) Return the turntable to the azimuth where the highest emission amplitude level was observed.
 - d) Vary the measurement antenna height again through 1 m to 4 m again to find the height associated with the maximum emission amplitude.
 - e) Record the measured emission amplitude level and frequency
- 6. Repeat step 5 for each emission frequency with the measurement antenna oriented in both the horizontal and vertical polarizations to determine the orientation that gives the maximum emissions amplitude.
- 7. Set-up the substitution measurement with the reference point of the substitution antenna located as near as possible to where the center of the EUT radiating element was located during the initial EUT measurement
- 8. Maintain the previous measurement instrument settings and test set-up, with the exception that the EUT is removed and replaced by the substitution antenna.
- 9. Connect a signal generator to the substitution antenna; locate the signal generator so as to minimize any potential influences on the measurement results. Set the signal generator to the frequency where emissions are detected, and set an output power level such that the radiated signal can be detected by the measurement instrument, with sufficient dynamic range relative to the noise floor.
- 10. For each emission that was detected and measured in the initial test
 - a) Vary the measurement antenna height between 1 m to 4 m to maximize the received (measured) signal amplitude.
 - b) Adjust the signal generator output power level until the amplitude detected by the measurement instrument equals the amplitude level of the emission previously measured directly in step 5 and step 6.
 - c) Record the output power level of the signal generator when equivalence is achieved in step b).
- 11. Repeat step 8 through step 10 with the measurement antenna oriented in the opposite polarization.
- 12. Calculate the emission power in dBm referenced to a half-wave dipole using the following equation:

Pe = Ps(dBm) - cable loss (dB) + antenna gain (dBd)

where

Pe = equivalent emission power in dBm

Ps = source (signal generator) power in dBm

NOTE—dBd refers to the measured antenna gain in decibels relative to a half-wave dipole.

13. Correct the antenna gain of the substitution antenna if necessary to reference the emission power to a half-wave dipole. When using measurement antennas with the gain specified in dBi, the equivalent dipole-referenced gain can be determined from:

gain (dBd) = gain (dBi) - 2.15 dB.

If necessary, the antenna gain can be calculated from calibrated antenna factor information

14. Provide the complete measurement results as a part of the test report.





10.4. Test Data

Pass

ERP&EIRP						
Band	Mode	Channel	(dBm)		Limit (dDm)	Result
Dallu	Mode	Charmer	Vertical	Horizontal	Limit (dBm)	Result
		9262	24.48	22.58		
	RMC	9400	24.59	20.65	<33.00	PASS
		9538	23.89	21.86		
WCDMA		9262	24.59	22.69		
Band II	HSDPA	9400	24.73	20.79	<33.00	PASS
(EIRP)		9538	24.05	22.02		
		9262	24.49	22.59	<33.00	PASS
	HSUPA	9400	24.58	20.64		
		9538	23.88	21.85		
		4132	20.35	19.63		PASS
	RMC	4183	20.17	17.98	<38.45	
		4233	18.96	18.78		
WCDMA		4132	20.50	19.78		PASS
Band V		4183	20.14	17.95	<38.45	
(ERP)		4233	18.93	18.75		
		4132	20.48	19.76		
	HSUPA	4183	20.19	18.00	<38.45	PASS
		4233	19.03	18.85		

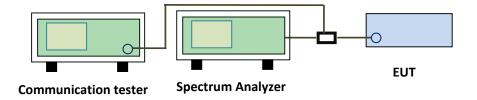


11. Frequency stability VS Voltage measurement

11.1. Test Standard and Limit

Applicable Standard:	Part 2.1055(d)(1)(2)
	Part 22.355
	Part 24.235
Limit:	2.5ppm

11.2. Test Setup



11.3. Test Procedure

- 1. The equipment under test was connected to an external DC power supply and input rated voltage.
- 2. The EUT output port was connected to communication tester.
- 3. The EUT was placed inside the temperature chamber at 25°C.
- 4. The power supply voltage to the EUT was varied ±15% of the nominal value measured at the input to the EUT.
- 5. Record the maximum frequency change.

11.4. Test Data

Pass

Please refer to Appendix F of the Appendix Test Data.

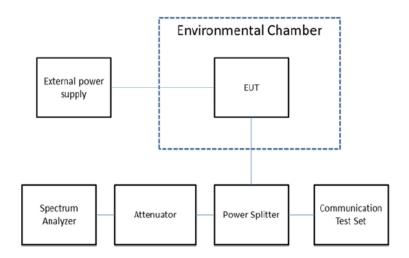


12. Frequency stability VS Temperature measurement

12.1. Test Standard and Limit

Applicable Standard:	Part 2.1055(a)(1)(b)
	Part 22.355
	Part 24.235
Limit:	2.5ppm

12.2. Test Setup



12.3. Test Procedure

- 1. The equipment under test was connected to an external DC power supply and input rated voltage.
- 2. The EUT output port was connected to communication tester.
- 3. The EUT was placed inside the temperature chamber.
- 4. Turn EUT off and set the chamber temperature to –30°C. After the temperature stabilized for approximately 30 minutes recorded the frequency.
- 5. Repeat step 4 measure with 10°C increased per stage until the highest temperature of +50°C reached.

12.4. Test Data

Pass

Please refer to Appendix F of the Appendix Test Data.



APPENDIX I -- TEST SETUP PHOTOGRAPH

Please refer to separated files Appendix I -- Test Setup Photograph_Licensed

APPENDIX II -- EXTERNAL PHOTOGRAPH

Please refer to separated files Appendix II -- External Photograph

APPENDIX III -- INTERNAL PHOTOGRAPH

Please refer to separated files Appendix III -- Internal Photograph

 End of Report	